

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Benjamin L. Hall, et al

Examiner:

Serial No:

Group Art Unit:

Filed:

For: SEMICONDUCTOR ARRAY TESTER

INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. §§ 1.56, 1.97 – 1.98Commissioner of Patents
Alexandria, VA 22313-1450

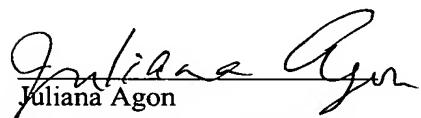
Dear Sir:

The Examiner's attention is hereby directed to the following reference(s) listed on the attached Form PTO-1449 for consideration in connection with the examination of the above-identified patent application. One copy of the reference(s) is enclosed.

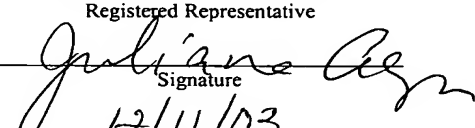
This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the enclosed documents constitute "prior art." If it should be determined that any of the submitted documents do not constitute "prior art" under United States law, applicant(s) reserve the right to present to the office the relevant facts and law regarding the appropriate status of such documents.

Applicant(s) further reserve the right to take appropriate action to establish the patentability of the disclosed invention over the enclosed references, should one or more of the references be applied against the claims of the present application.

Respectfully submitted,


Juliana Agon
Registration No. 33,468
Corning Incorporated
SP-TI-03-1
Corning, NY 14831
607-974-6574

Date: 12/11/03

I hereby certify that this correspondence is being deposited with the United States Postal Service as EXPRESS MAIL in an envelope addressed to Commissioner of Patents, Alexandria, Va 22313-1450 on <u>December 11, 2003</u>	
Date of Deposit	
Juliana Agon	
Name of applicant, assignee, or Registered Representative	
	
Signature	
<u>12/11/03</u>	
Date of Signature	
EXPRESS MAIL NO. EV 327190289 US	

FORM PTO-1449 (MODIFIED) LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	ATTORNEY DOCKET NO.	SERIAL NO.
	SP03-174	
	APPLICANT Benjamin L. Hall, et al.	
	FILING DATE	GROUP:

REFERENCE DESIGNATION				U.S. PATENT and PUBLICATION DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
	AA	5,703,892	12/30/97	Claisse, et al	372	32	
	AB	5,767,507	6/16/98	Unlu, et al	250	225	
	AC	5,949,534	9/7/99	Guttman, et al	356	121	
	AD	6,175,446	1/16/01	Alphonse	359	344	
	AE	6,330,378	12/11/01	Forrest, et al	385	14	
	AF	6,483,580	11/19/02	Xu, et al	356	300	
	AG	6,501,260	12/31/02	Hu, et al	324	158.1	
	AH	2003/0095264	5/22/03	Ruchet	356	491	
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation Yes No
	AL	WO 01/36931	5/25/01	PCT			
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)	
AR	"Theory of Spontaneous Emission Noise in Open Resonators and its Application to Lasers and Optical Amplifiers" C. H. Henry J. of Lightwave Technology, Vol. Lt-4, No. 3, March 1986
AS	"A Comparison of Far-Field Methods for Determining Mode Field Diameter of Single-Mode Fibers Using Both Gaussian and Petermann Definitions" T. J. Drapela, et al J. of Lightwave Technology, Vol. 7, No. 8, August 1989
AT	
AU	
AV	
AW	

EXAMINER: _____ DATE CONSIDERED: _____

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.